Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/639,144	LU, CHUN CHIAN	
Examiner	Art Unit	
EVA Y. PUENTE	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	316	3/19/2008	E.P		
375	343	3/19/2008	E.P		
375	346	3/19/2008	E.P		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEAR (INCLUDING SI	CH NOTES EARCH STRATEGY	′)
·	DATE	EXMR
updated search	3/19/2008	E.P